

Application/Control No. 10/720,336

Examiner

Brian E. Miller

Applicant(s)/Patent under Reexamination BAE, BYOUNG-YOUNG

Art Unit 2627

				ISSUE	CL	<u>.AS</u>	SIF	ICAI	ION			
	INTERNATIONAL CLASSIFICATION											
CLASS SUBCLASS   720 652					CL	AIMED		NON-CLAIMED				
			652		G	11	В	33	/12			/
CROSS REFERENCES						11	В	17	/04			
CLASS	SUBCLAS	SS (ONE S	G									
720	653								1			/
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(Assistant Examiner) (Date)

Brian E. Miller 7/9/06

(Primary Examiner) (Date)

**Total Claims Allowed: 11** 

O.G. O.G. Print Claim(s) Print Fig. 11 2, 5

	Claims renumbered in the same order as presented by applicant										□ СРА			☐ T.D.			☐ R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121			151			181
2	2			32			62	}		92			122			152		L	182
_ 3	3			33	}		63			93			123			153			183
7	4			34	]		64	]		94			124			154			184
8	5			35	]		65			95			125			155			185
4	6			36			66			96			126			156			186
6	7			37			67			97			127			157			187
5	8			38			68			98			128			158			188
9	9			39			69	1		99			129			159			189
10	10			40			70			100			130			160			190
11	11	1		41			71	]		101			131	11		161			191
	12			42			72			102			132			162			192
	13			43			73	1		103			133			163			193
	14			44			74			104		8	134			164			194
	15			45			75			105			135			165			195
	16			46			76	]		106			136			166			196
	17	1		47			77	1		107			137			167			197
	18	1		48			78	1		108			138			168			198
	19	1		49	1		79			109	1		139			169			199
	20	ĺ		50			80	1		110			140			170			200
	21			51	1		81	1		111			141			171			201
	22			52	1		82	1		112			142			172			202
	23			53			83	1		113			143			173			203
	24			54	1		84	1		114			144			174			204
	25			55	1		85	1		115			145			175			205
	26	1		56	1		86	1		116			146			176			206
	27	1		57	1		87	1		117	1		147			177			207
	28	1		58	1		88	1		118			148			178			208
	29	1		59	1		89	1		119	İ		149			179			209
	30			60			90	1		120			150			180			210